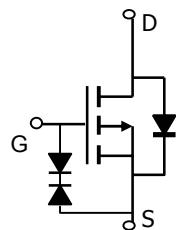
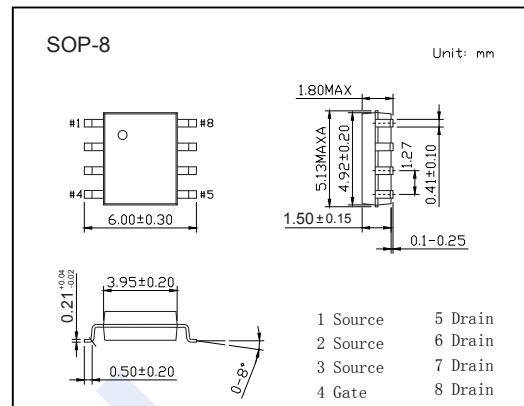


## P-Channel MOSFET

## AO4423 (KO4423)

## ■ Features

- $V_{DS} (V) = -30V$
- $I_D = -15 A (V_{GS} = -20V)$
- $R_{DS(ON)} < 7m\Omega (V_{GS} = -20V)$
- $R_{DS(ON)} < 8.5m\Omega (V_{GS} = -10V)$
- $R_{DS(ON)} < 12 m\Omega (V_{GS} = -6 V)$
- ESD Rating: 3000V HBM

■ Absolute Maximum Ratings  $T_a = 25^\circ C$ 

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	$V_{DS}$	-30	V
Gate-Source Voltage	$V_{GS}$	$\pm 25$	
Continuous Drain Current	$I_D$	-15	A
		-12.1	
Pulsed Drain Current	$I_{DM}$	-80	
Power Dissipation	$P_D$	3.1	W
		2	
Thermal Resistance.Junction- to-Ambient	$R_{thJA}$	40	$^\circ C/W$
		75	
Thermal Resistance.Junction- to-Lead	$R_{thJL}$	24	
Junction Temperature	$T_J$	150	$^\circ C$
Junction Storage Temperature Range	$T_{stg}$	-55 to 150	

## P-Channel MOSFET

### AO4423 (KO4423)

#### ■ Electrical Characteristics Ta = 25°C

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	V <sub>DSS</sub>	I <sub>D</sub> =-250 μA, V <sub>GS</sub> =0V	-30			V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>Ds</sub> =-24V, V <sub>GS</sub> =0V			-100	nA
		V <sub>Ds</sub> =-24V, V <sub>GS</sub> =0V, T <sub>J</sub> =55°C			-500	
Gate-Body leakage current	I <sub>GSS</sub>	V <sub>Ds</sub> =0V, V <sub>GS</sub> =±20V			±1	uA
		V <sub>Ds</sub> =0V, V <sub>GS</sub> =±25V			±10	
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>Ds</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250 μA	-2		-3.5	V
Static Drain-Source On-Resistance	R <sub>Ds(on)</sub>	V <sub>GS</sub> =-20V, I <sub>D</sub> =-15A			7	mΩ
		V <sub>GS</sub> =-20V, I <sub>D</sub> =-15A T <sub>J</sub> =125°C			8.6	
		V <sub>GS</sub> =-10V, I <sub>D</sub> =-15A			8.5	
		V <sub>GS</sub> =-6V, I <sub>D</sub> =-10A			12	
On state drain current	I <sub>D(on)</sub>	V <sub>GS</sub> =-10V, V <sub>Ds</sub> =-5V	-80			A
Forward Transconductance	g <sub>FS</sub>	V <sub>Ds</sub> =-5V, I <sub>D</sub> =-15A		43		S
Input Capacitance	C <sub>iss</sub>			4632		pF
Output Capacitance	C <sub>oss</sub>	V <sub>GS</sub> =0V, V <sub>Ds</sub> =-15V, f=1MHz		1034		
Reverse Transfer Capacitance	C <sub>rss</sub>			705		
Gate resistance	R <sub>g</sub>	V <sub>GS</sub> =0V, V <sub>Ds</sub> =0V, f=1MHz		2.5		Ω
Total Gate Charge	Q <sub>g</sub>	V <sub>GS</sub> =-10V, V <sub>Ds</sub> =-15V, I <sub>D</sub> =-15A		82		nC
Gate Source Charge	Q <sub>gs</sub>			16.8		
Gate Drain Charge	Q <sub>gd</sub>			23		
Turn-On DelayTime	t <sub>d(on)</sub>	V <sub>GS</sub> =-10V, V <sub>Ds</sub> =-15V, R <sub>L</sub> =1Ω, R <sub>GEN</sub> =3Ω		18.5		ns
Turn-On Rise Time	t <sub>r</sub>			20		
Turn-Off DelayTime	t <sub>d(off)</sub>			55		
Turn-Off Fall Time	t <sub>f</sub>			30		
Body Diode Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> =-15A, dI/dt=100A/us		43		nC
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			38		
Maximum Body-Diode Continuous Current	I <sub>s</sub>				-4.2	A
Diode Forward Voltage	V <sub>SD</sub>	I <sub>s</sub> =-1A, V <sub>GS</sub> =0V			-1	V

Note : The static characteristics in Figures 1 to 6 are obtained using <300 μs pulses, duty cycle 0.5% max.

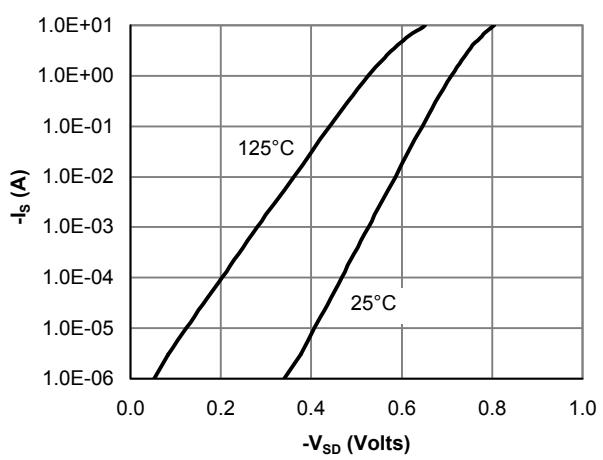
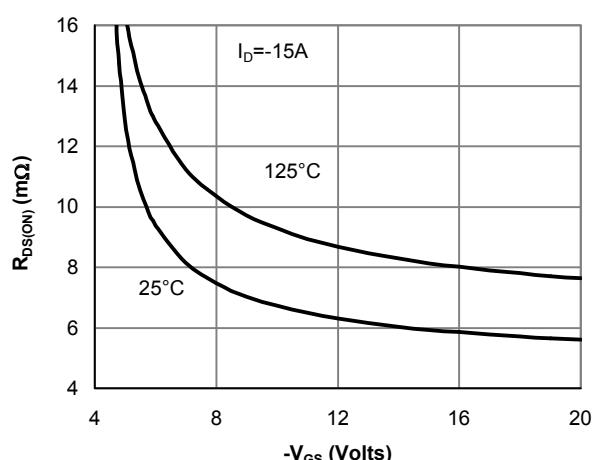
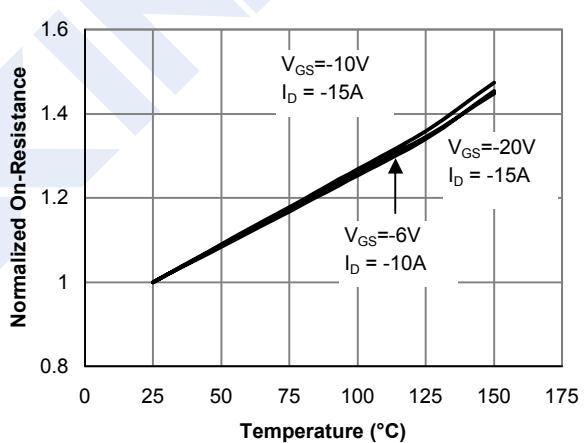
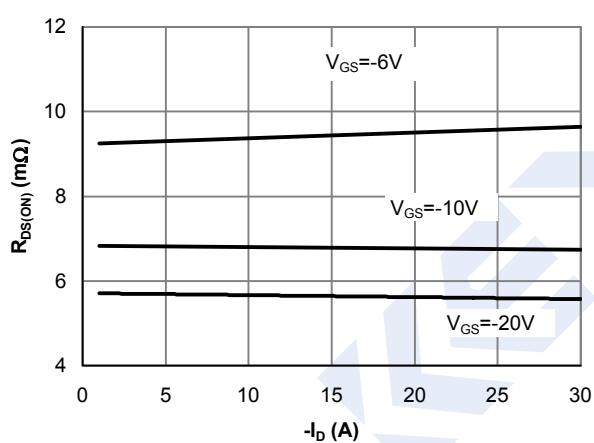
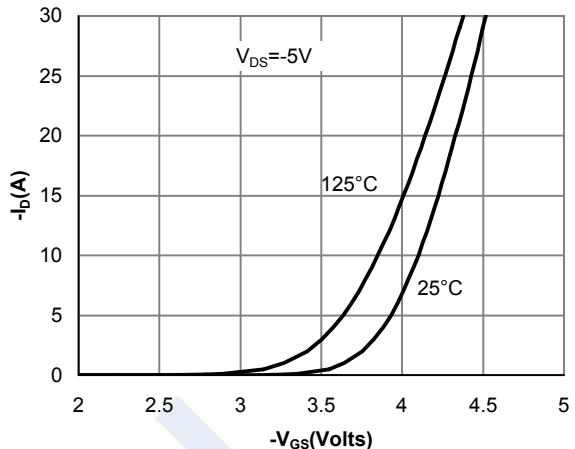
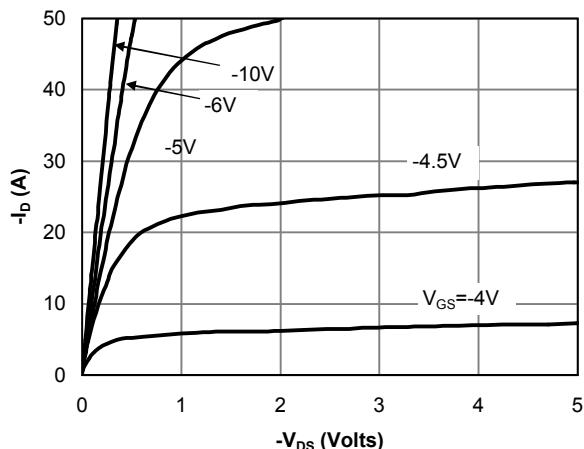
#### ■ Marking

Marking	4423 KC****
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## P-Channel MOSFET

### AO4423 (KO4423)

#### ■ Typical Characteristics



## P-Channel MOSFET

### AO4423 (KO4423)

#### ■ Typical Characteristics

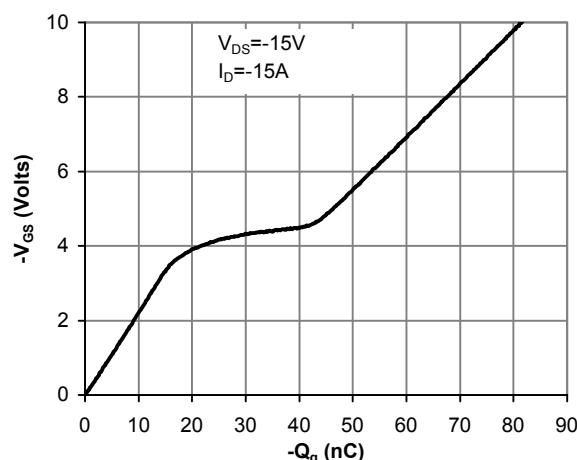


Figure 7: Gate-Charge Characteristics

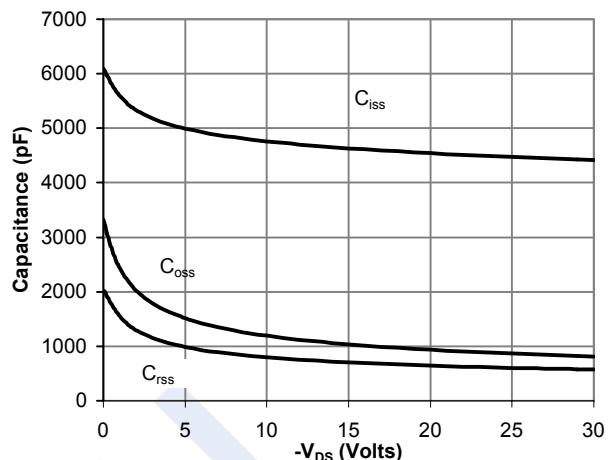


Figure 8: Capacitance Characteristics

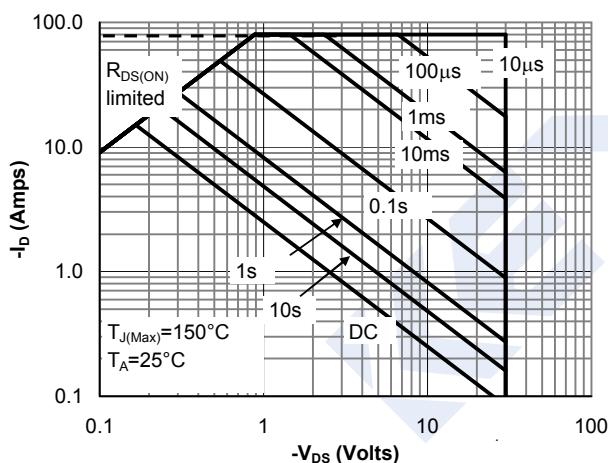


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

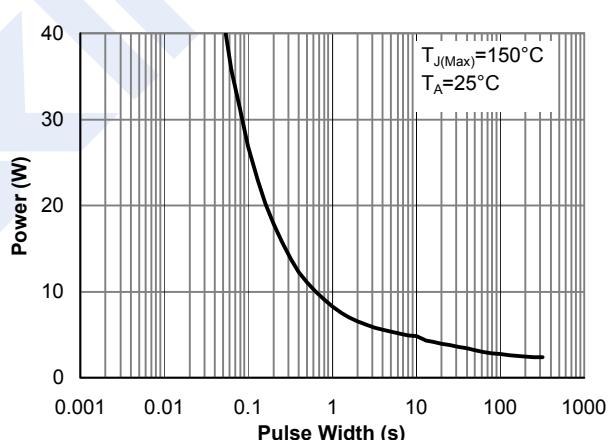


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

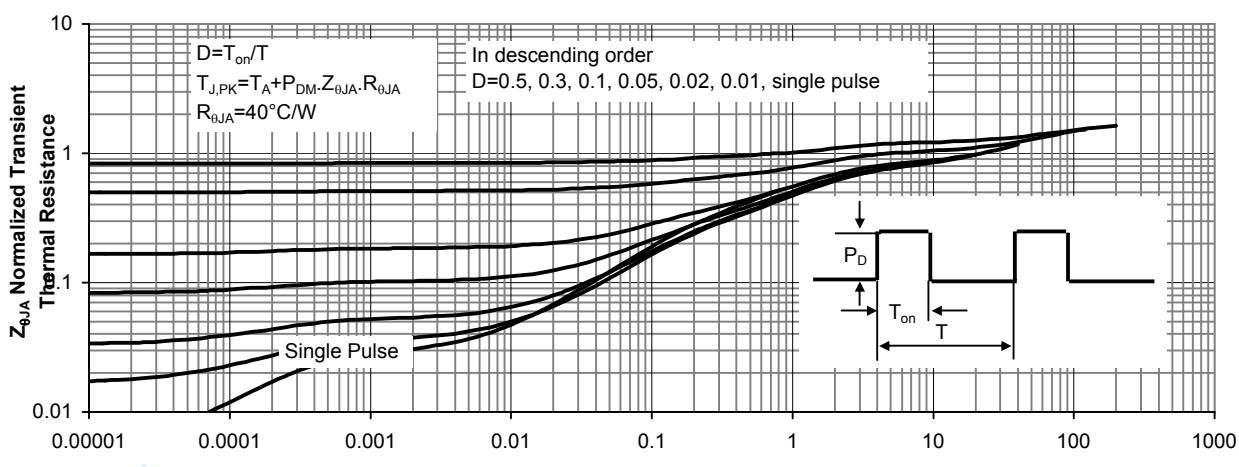


Figure 11: Normalized Maximum Transient Thermal Impedance